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ASSESSMENT GROUP SANTA MONICA CA\*

DEMONSTRATION MODEL SYSTEM. VOLUME V. SLIDE-RULE MODEL SYSTEM U--ETC(U)

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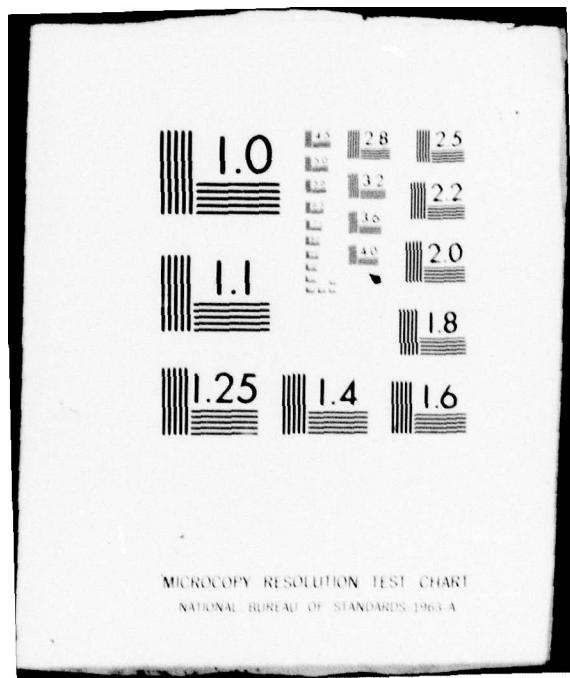
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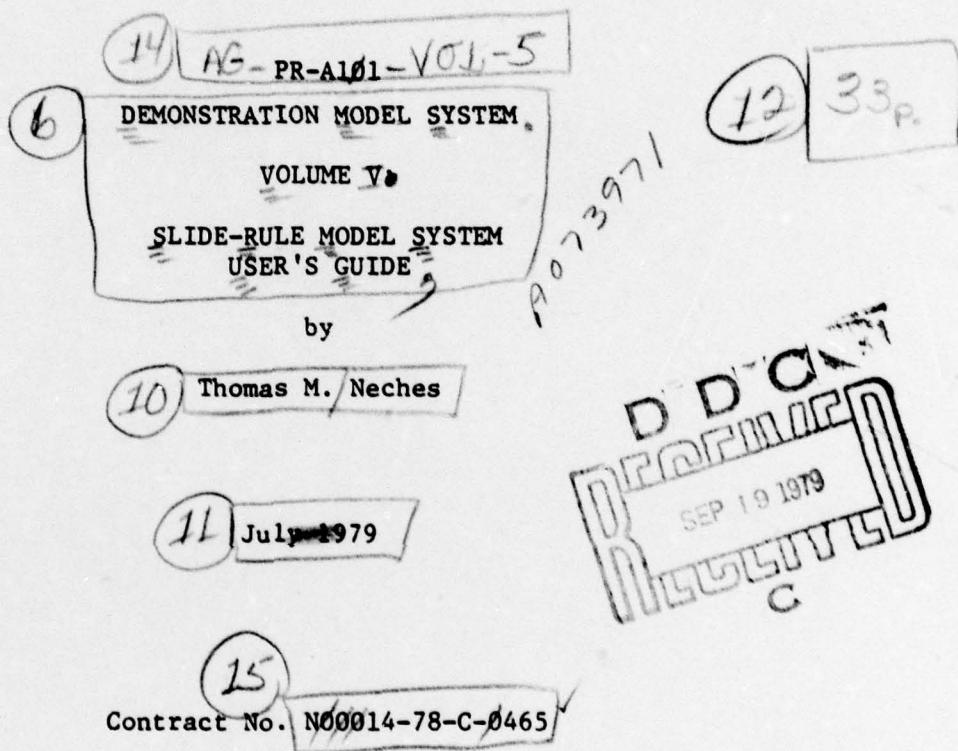




**theassessmentgroup**

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710 Wilshire Boulevard, Suite 301  
Santa Monica, California 90401  
213/394-6778



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## INTRODUCTION

The Level I "Slide-Rule" Cost Model System is implemented on a Texas Instruments TI-59 programmable calculator coupled to a TI-PC-100A Print/Security Cradle.

The model system consists of four linked programs, the Top-Down Model, (TDM), the Lowest Removable Assembly Model (LRAM), the System Aggregation Model (SAM), and the System Confidence Model (SCM). Each program and its data input sets are stored on magnetic cards. The output of each program is used as input to succeeding programs, together with additional input data.

The TI-59 has 120 program/data registers, which can be partitioned as desired between program instruction steps and data memory registers. When the calculator is turned on, 60 memory registers are automatically reserved for data storage. All programs other than the TDM use the default allocation. The TDM, however, uses only 40 registers for data storage; the remainder is used to store the program code. Therefore, when running the TDM, the first step after turning on the calculator will be to repartition the memory registers.

Model output and all cost inputs are given in thousands of dollars. TDM running time is approximately 1 minute; LRAM running time is approximately 40 seconds (slightly greater if the LRA is coded depot repair); the SAM requires approximately 10 seconds per aggregation run; SCM running time is approximately 10 seconds per LRA input.

If program execution is interrupted in the models of a run, it is likely that the calculator will be in the Fix 2 display mode. If this

occurs, press **INV** **2nd** **4** before reading in any new data cards.

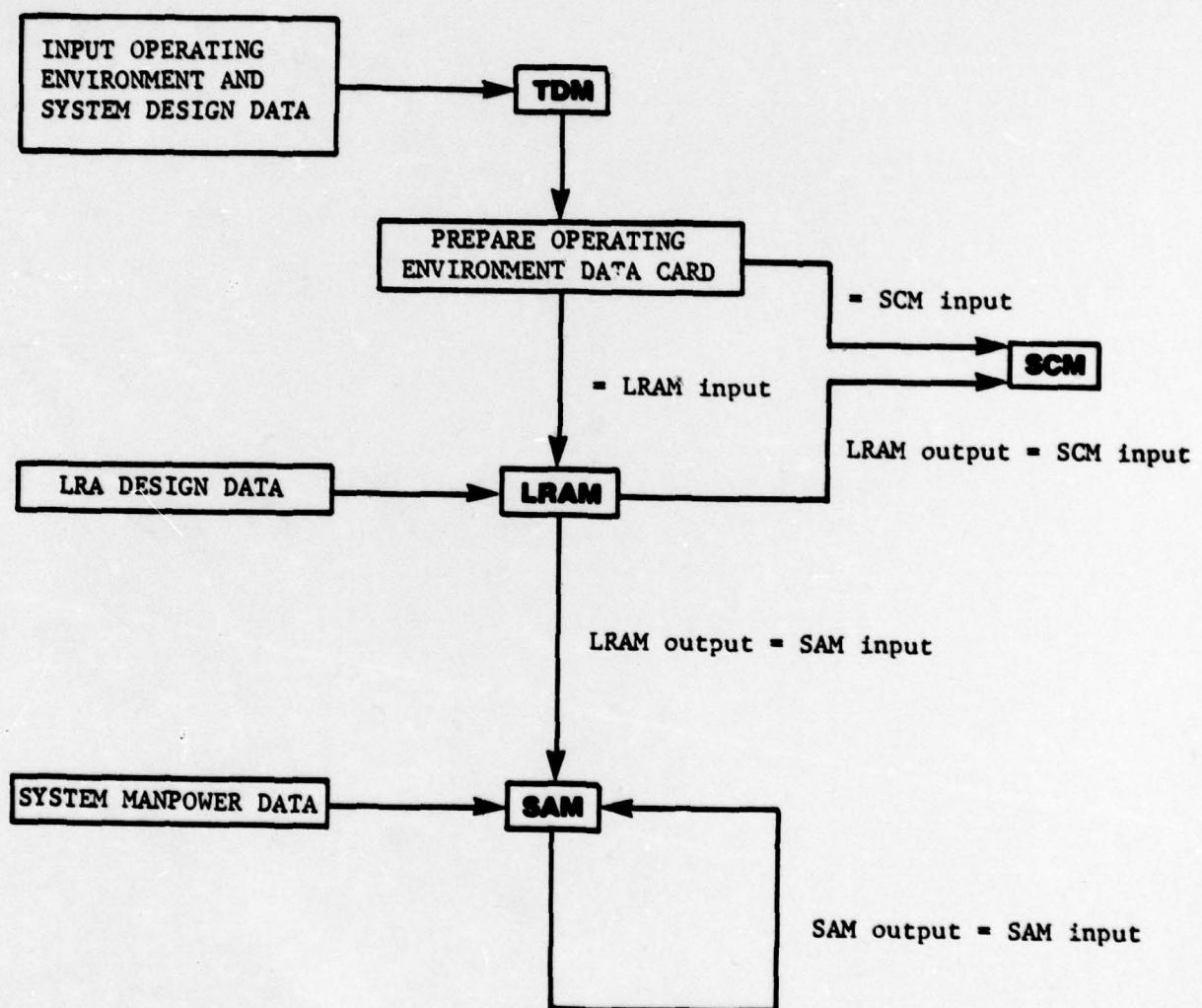
In order to conserve memory register space, several constants describing the operating environment of the system have been incorporated into the program code. A list of these constants and their location in the program is presented for each model. Values of the code constants can be altered by adjusting the program code. The routine for altering the values of the code constants is the following:

1. Press **GTO**.
2. Enter Program Location.
3. Press **LRN**.
4. Enter New Value.
5. Press **LRN**.

New values of the code constants must have *exactly* the same numbers of decimal places (including any decimal points) as the original value. (For example, 1.0 may be replaced by 10., .01, 100, 9.5, 000, etc., but *not* by 1, 1.00, .0, 10.0, 2., etc.) Failure to do this will almost certainly cause program execution errors.

Figure 1 presents the input/output linkage between the four models. Program operation for the TDM, LRAM, SAM and SCM is described in the User's Guide Supplements A, B, C and D. Each subsection is a self-contained unit presenting program operating instructions, data input/output instructions, code constant program locations, and program data register allocation and usage.

Figure 1 Level I Input/Output



**USER'S GUIDE SUPPLEMENT**  
**FOR TOP-DOWN MODEL**

Figure A-1 TDM Operating Instructions

Step	Procedure	Press	Display/Printer
1	Repartition memory	4 [2nd] [ ] 17	639.39
2	Load program and input data	[CLR] (load banks 1, 2, 3, 4)	1, 2, 3, 4
3	Alter input data* (i.e., set MTBF = 240 hrs.)	240 [STO] 21	240.
4	Run program  (To suppress printing of $C_j$ press [2nd] [SET] j. To restore printing option press  [INV] [2nd] [SET] j.+  To suppress discounting option press [2nd] [SET] 0.  To restore option press  [INV] [2nd] [SET] 0.)  Both $C_8$ and $C_9$ are operated by flag 8. Do not set flag 9 for any reason.	[A]	$C_1$ = maintenance wage $C_2$ = maintenance training $C_3$ = operator wage $C_4$ = operator training $C_5$ = production and spares $C_6$ = support and test eqpt. $C_7$ = repair $C_8$ = item entry and management $C_9$ = documentation  life cycle cost = $\sum C_j$
5	For new design variant go to Step 3		
6	Record input data for future use	3 [2nd] [ ] (load bank 3)  4 [2nd] [ ] (load bank 4)	3.  4.

\* See Figure A-3.

Figure A-2 Altering Operating Environment Output Data Card

Step	Procedure	Press	Display/Printer
1	Load Operating Environment data card*	<b>CLR</b> (load Bank 3)	3.
2	Alter input data** (example: set L = 6.67)	6.67 <b>STO</b> 47	6.67
3	Record op. env. data card for use in LRAM and SCM	3 <b>2nd</b> <b>M</b> (load Bank 3)	3.

\*Turn calculator off for a few seconds to insure normal partitioning (479.59).

\*\*See Figure 2.5.

Figure A-3 TDM Input Data  
(Sample Data Collection Worksheet)

Variable Name	Units	(Sample) Value	Storage Address	Definition
$r_1$	---		02	Fraction LRA's coded local repair
LRT	weeks		03	Average local repair response time
$r_2$	---		06	Fraction LRA's coded depot repair
D	weeks		07	Deployment period
n'	---		10	Total # LRA's in system
n	---		11	# Unique LRA types in system
s	---		12	Ratio peak operating hrs. per wk. to av. op. hrs./wk.
N	---		13	# Ships
$AN_m$	men		14	On-board available maintenance personnel
$BN_m$	\$'000		15	Annual billet cost for maintenance personnel
$AN_o$	men		17	On-board available operators
$BN_o$	\$'000		18	Annual billet cost for operators
$TC_o$	\$'000		19	"C" School training cost for operators
LC	years		20	System life cycle
MTBF	hours		21	System mean time between failure
$UC_L$	\$'000		22	Estimated unit production cost at lot size LOT
$l$	---		23	LOT size used for $UC_{LOT}$
Q	---		24	# Systems per ship
AHR	hrs/wk		25	Av. system operating hrs./ operating wk.
MTTRS	manhour		26	Mean time to repair system
SM	manhrs/ week		27	Weekly scheduled maintenance manhour requirement

Figure A-3 TDM Input Data (cont'd)

Variable Name	Units	(Sample) Value	Storage Address	Definition
TC <sub>m</sub>	\$'000		28	System level maintenance training requirement
θ	men		29	# Operators/system
STE	\$'000		30	System level support and test equipment purchase cost
COD	\$'000		31	Cost of repair at contractor operated depot
RP	\$'000		32	Repair materials cost for local repair of LRA
DOC	\$'000		33	System level documentation cost

Figure A-4 TDM Code Constant Program Location

Variable Name	Units	Program Location	Current Value	Available Program Steps*	Definition
BG	\$ '000	062	10.5	4	Annual billet cost for general labor personnel
TA	\$ '000	090	10.0	4	Average cost of "A" school training course
TOR	---	099	.45	3	Annual personnel turnover rate
K*	---	230	.95	3	Confidence level against on-board spare stock-out
DRT/d**	weeks	288	13	2	(Depot response time = 26 wks.)/(# depots = 2)
Z <sub>b</sub>	---	295	1.65	4	Standard deviation for .95 confidence level against LRA stock-out at depot
d**	---	305	2	1	# Depots
h	---	334	2	1	# Deployments/year
1-COND	---	355	.98	3	1 - (Condemnation Rate = .02)
log RRATE/ log 2	---	374	.15	4	Learning curve reduction factor = log .90 / log 2
$\rho$	---	384	.10	3	Discount rate
$\tilde{M}$	---	430	1.0	3	Ratio (MTTR <sub>LRA</sub> /MTTR <sub>SYS</sub> )
WH <sub>m</sub> •U	hr./wk.	445	53	2	(Maintenance personnel wkly. avail. work hrs. = 67)•(Util. Rate = .8)
$\tilde{T}$	---	456	1.0	3	Ratio (TC <sub>LPA</sub> /TC <sub>SYS</sub> )

\*Includes decimal point and change-sign operator.

\*\*Altering d requires altering DRT/d as well.

Figure A-4 TDM Code Constant Program Location (cont'd)

Variable Name	Units	Program Location	Current Value	Available Program Steps	Definition
WH <sub>o</sub>	hr./wk.	492	74	2	Operator wkly. available work hrs.
S̄	---	529	1.0	3	Ratio (STE <sub>LRA</sub> /STE <sub>SYS</sub> )
m	---	537	.12	3	Annual support of support eqpt. factor
IEC	\$ '000	569	.45	3	Item entry cost
IMC	\$ '000	573	.23	3	Item management cost
PP	---	583	1.0	3	Av. unique components per LRA
D̄	---	611	1.0	3	Ratio (DOC <sub>LRA</sub> /DOC <sub>SYS</sub> )

Figure A-5 Operating Environment Variable Card\*

Variable Name	Units	(Sample) Value	Storage Address	Definition
Q	---		30	# Systems per ship
AHR	hr./wk.		31	Av. system operating hr./operating week
s	---		32	Ratio peak operating hrs. per wk. to av. operating hrs. per week
LRT	weeks		33	Average local response time
D	week		34	Deployment period
K	---		35	Desired LRA confidence level**
XD	weeks		36	Lead time if depot stock-out
N			37	# Ships
DRT	---		38	Depot response time
t	---		39	Lot size used for unit cost estimations
1-COND	---		40	1-(condemnation rate)
log RRATE/ log 2	---		41	Learning curve factor
IEC+IMC-L	\$'000		42	Item entry and management factor
COD	\$'000		43	Cost of repair at contractor operated depot
AN	men		44	Maintenance manpower available to LRA**
BN	\$'000		45	Annual billet cost for trained maintenance personnel

\*This card, prepared by the system designer, is input to the LRAM and SCM.

\*\*Value may vary for different LRA's.

Figure A-5 Operating Environment Variable Card (cont'd)

Variable Name	Units	(Sample) Value	Storage Address	Definition
BG	\$'000		46	Annual billet cost for general labor personnel
L	yrs.		47	Discounted life cycle
TA	\$'000		48	"A" School course cost for maintenance personnel
(1+TOR•L)	---		49	Discounted personnel attrition factor
(1+mL)	---		50	Discounted support and test equipment maintenance factor

Figure A-6 TDM Memory Register Allocation

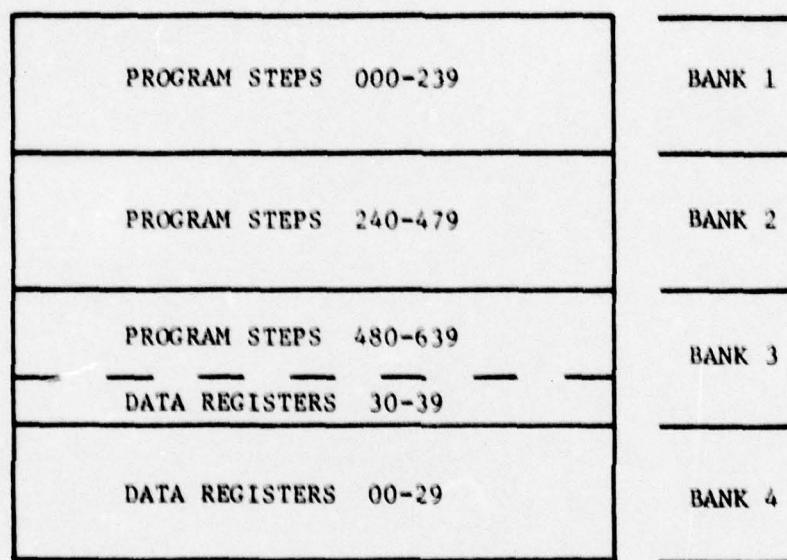


Figure A-7 TDM Data Register List

BANK 4

00	indirect
01	hold, u, indirect flg
02	LRT
03	S <sub>1</sub> , pL
04	K, A
05	r <sub>1</sub>
06	D
07	S <sub>2</sub> , S'
08	K <sub>2</sub> , UC
09	r <sub>2</sub>
10	n
11	n
12	s
13	N
14	AN <sub>m</sub>
15	BN <sub>m</sub>
16	TC <sub>m</sub>
17	AN <sub>o</sub>
18	BN <sub>o</sub>
19	TC <sub>o</sub>
20	LC
21	MTBF
22	UC <sub>l</sub>
23	l
24	Q
25	AHR
26	MTTRS
27	SM
28	TS <sub>m</sub>
29	θ

BANK 3

30	STE	●
31	COD	●
32	RP	●
33	DOC	●
34	SPARES, S	
35	K, B	
36	λ'', h·D	
37	λ, LCC	
38	V	
39	r <sub>1</sub> + r <sub>2</sub>	
40		
41		
42		
43		
44		
45		
46		
47		
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60		

● Marks input variable

**USER'S GUIDE SUPPLEMENT**  
**FOR LOWEST REMOVABLE ASSEMBLY MODEL**

Figure B-1 LRAM Operating Instructions

Step	Procedure	Press	Display/Printer
1	Load program	<b>CLR</b> (load Bank 1) <b>CLR</b> (load Bank 2)	1. 2.
2	Load operating environment data card	<b>CLR</b> (load Bank 3)	3.
3	Load input data	<b>CLR</b> (load Bank 4)	4.
4	Alter input data*	1000 <b>STO</b> 1 4	1000.
5	Run program  (To suppress printing of $C_j$ , $j = 2-8$ , press <b>2nd</b> <b>M</b> . To restore printing option press  <b>INV</b> <b>2nd</b> <b>M</b> . j.  Note: there is no $C_1$ .)	<b>A</b>	$C_2$ WAGE $C_3$ TRN $C_4$ HRD $C_5$ STE $C_6$ RPR $C_7$ IEMC $C_8$ DOC  $\sum C_j$ *LCC
6	For new design variant  go to Step 4		
7	Record input/output data	4 <b>2nd</b> <b>W</b>	4.  (load Bank 4)

\*See Figure B-2.

Figure B-2 LRAM Data Input Instructions

(Sample Data Collection Worksheet)

Variable Name	Units	(Sample) Value	Storage Address	Definition
"IDEN"	---		11	OP Code for LRA identifier*
q	---		12	Total # of units in the system
$\delta$	---		13	Ratio (LRA oper. hrs./system op. hrs.)
MTBF	hrs.		14	Mean time between failure
$r_1$	---		15	Local repair LOR switch**
$r_2$	---		16	Depot Repair LOR switch**
$UC_L$	\$'000		17	Estimated unit cost at lot size (specified in op. envir. data)
MTTRS	manhour		18	Mean time to repair system due to LRA failure
MTTR	manhour		19	Mean time to repair LRA***
TFI	\$'000		20	Specific training cost to remove and replace LRA
TR	\$'000		21	Training cost to repair LRA***
STE	\$'000		22	Purchase cost of system support
$STE_{rpr}$	\$'000		23	Purchase cost of support and test eqpt. to repair LRA***
c	---		24	Total # of components in LRA
$\bar{c}$	---		25	# of new components unique to LRA
DOC	\$'000		26	Documentation cost to describe LRA
$DOC_{rpr}$	\$'000		27	Documentation cost for repair of LRA***

\*A four letter identifier used when the LRAM output is input to the SAM.

\*\*For local repair set  $r_1 = 1$ ,  $r_2 = 0$ .

For depot repair set  $r_1 = 0$ ,  $r_2 = 1$ .

For discard set  $r_1 = 0$ ,  $r_2 = 0$ .

\*\*\*If coded local repair.

Figure B-3 LRAM Code Constant Program Location

Variable Name	Units	Program Location	Current Value	Available Program Steps	Definition
d	---	221 and 228*	2	1	# Depots
h	---	247	2	1	# Deployments/yr.

\*d must be altered in both locations.

Figure B-4 LRAM Memory Register Allocation

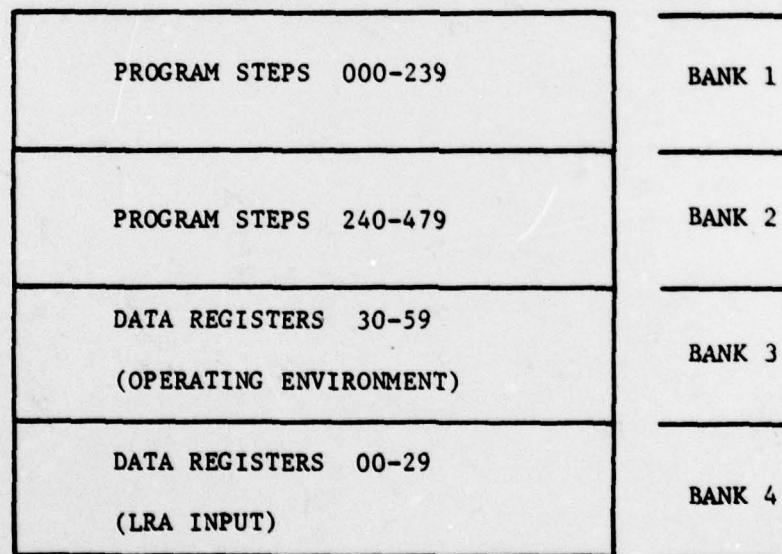


Figure B-5 LRAM Data Register Listing

BANK 4

00	ind. lbl.
01	ind. C <sub>j</sub>
02	LCC, hold
03	T <sub>C<sub>0</sub></sub> , C <sub>4</sub> , A, X
04	C <sub>5</sub> , S
05	C <sub>6</sub> , S'
06	C <sub>7</sub> , λ
07	C <sub>8</sub> , r <sub>1</sub> + r <sub>2</sub> , K
08	C <sub>9</sub> , B
09	M' <sub>m</sub> , hold
10	K(XD)
11	"IDEN"
12	q
13	δ
14	MTBF
15	r <sub>1</sub>
16	r <sub>2</sub>
17	UC <sub>g</sub>
18	MTTRS
19	MTTR
20	TS
21	TR
22	STE
23	STE <sub>rpr</sub>
24	c
25	̄c
26	DOC
27	DOC <sub>rpr</sub>
28	B. K(t)
29	λ

LRAM Input/Output Card

● Marks Input Variable

BANK 3

30	Q
31	AHR
32	s
33	LRT
34	D
35	K
36	XD
37	N
38	DRT
39	ℓ
40	1-COND
41	log RRATE/log 2
42	IEC+IMC•L
43	COD
44	AN
45	BN
46	BG
47	L
48	TA
49	(1+TOR•L)
50	(1+mL)
51	"WAGE"
52	"TRN"
53	"HRDW"
54	"STE"
55	"RPR"
56	"IEMC"
57	"DOC"
58	"*LCC"
59	hold UC

Op. Env. Data Card

**USER'S GUIDE SUPPLEMENT  
FOR SYSTEM AGGREGATION MODEL**

Figure C-1 SAM Operating Instructions

Step	Procedure	Press	Display/Printer
1	Load program	<b>CLR</b> (load Bank 1) <b>CLR</b> (load Bank 2)	1. 2.
2	Initialize aggregation registers(load initializing card)	<b>CLR</b> (load Bank 3)	3.
3	Load output card for LRA <sub>i</sub> *	<b>CLR</b> (load Bank 4)	4.
4	Aggregate  Add QIPA LRA's  Remove QIPA LRA's	QIPA <b>A</b>  QIPA <b>B</b>	QIPA IDEN  -QIPA IDEN
5	Repeat Step 3 and 4 for all LRA's in system		
6	Load system manpower cost card	<b>CLR</b> (load Bank 4)	4.
7**	Alter system input data (i.e., set SM = 2 hrs.)	2 <b>STO</b> 13	2.
8**	Record new system data for future use	4 <b>2nd</b> <b>WIP</b> (load Bank 4)	4.

\*Output can also from SAM.

\*\*This step may be skipped.

Figure C-1 SAM Operating Instructions (cont'd)

Step	Procedure	Press	Display/Printer
9	Compute system costs	<b>C</b>	$c_1 \text{ MUGE}$ $c_2 \text{ MTRN}$ $c_3 \text{ DUGE}$ $c_4 \text{ DTRN}$ $c_5 \text{ HRDW}$ $c_6 \text{ STE}$ $c_7 \text{ RPR}$ $c_8 \text{ IEMC}$ $c_9 \text{ DOC}$ $\sum c_j \text{ +LCC}$
10	For new design variant go to Step 3 or Step 6		
11	Compute system MTBF and MTTR	<b>D</b>	MTBF      MTBF MTTR      MTTR
12	Record output data for future use (as input to SAM)	4 <b>2nd</b> <b>Write</b> (load Bank 4)	4.

Figure C-2 SAM Input Data  
(Sample Data Collection Worksheet)

Variable Name	Units	(Sample) Value	Storage Address	Definition
s	---		05	Ratio peak to average weekly operating hours
Q	---		06	# Systems per ship
BG	\$'000		07	Annual billet cost for general labor personnel
N	---		08	# Ships
L	yrs.		09	Discounted life cycle
AHR	hrs/wk.		10	Av. weekly operating hrs.
"SYS"	---		11	System identifier*
q	---		12	# Units per system**
SM	manh./week		13	Weekly scheduled maintenance requirement
AN <sub>m</sub>	men		14	Available pool of trained maintenance personnel
BN <sub>m</sub>	\$'000		15	Annual billet cost of trained maintenance personnel
TA <sub>m</sub>	\$'000		16	"A" School course cost for maintenance personnel
TC <sub>m</sub>	\$'000		17	System orientation course cost for maintenance personnel
θ	men		18	# Operators/unit
AN <sub>o</sub>	men		19	Available pool of trained operators
BN <sub>o</sub>	\$'000		20	Annual billet cost of trained operators

\*Used only if SAM output is used on SAM input.

\*\*q = 1 if SAM us used system level.

Figure C-2 SAM Input Data (cont'd)

Variable Name	Units	(Sample) Value	Storage Address	Definition
TA <sub>o</sub>	\$'000		21	"A" school course cost for operators
TC <sub>m</sub>	\$'000		22	System orientation course cost for operators
PT <sub>l</sub>	\$'000		23	Estimated system assembly cost at lot size l
l	---		24	Lot size used for system assembly cost estimate
log RRATE /log 2	---		25	Learning curve factor (log reduction rate)/log 2
DOC	\$'000		26	System level documentation cost
STE	\$'000		27	System level support and test equipment cost
(1+mL)	---		28	Discounted support of support equipment factor
(1+TOR·L)	---		29	Discounted personnel attrition factor

Figure C-3 SAM Memory Register Allocation

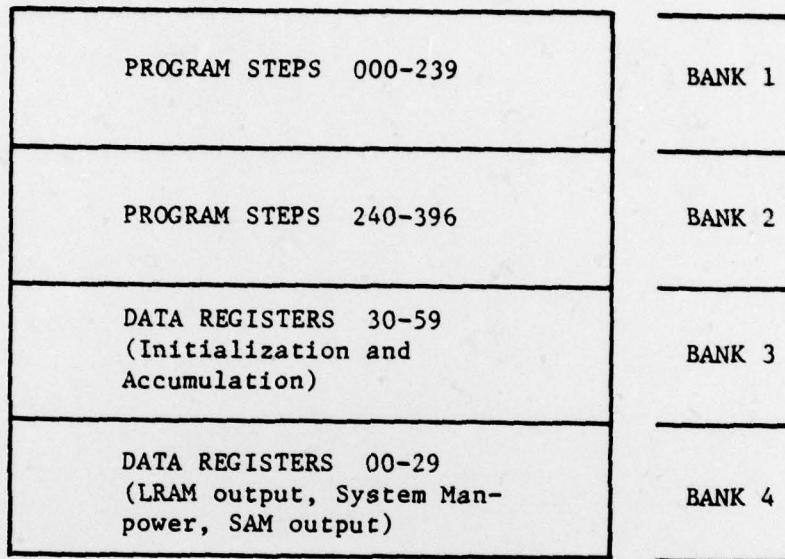


Figure C-4 SAM Data Register Listing

BANK 4

35	
31	
30	
03	/ TC <sub>o</sub>
04	/ HRDW
05	s / STE
06	Q / RPR
07	BG / IEMC
08	N / DOC
09	L / M̄ <sub>m</sub>
10	A <sub>RR</sub>
11	"SYS" / "SYS"
12	q / q
13	SM
14	AN <sub>m</sub> / MTBF
15	BN <sub>m</sub> / r = 0
16	TA <sub>m</sub>
17	TC <sub>m</sub>
18	θ / MTTR
19	AN <sub>o</sub>
20	BN <sub>o</sub> / TC <sub>m</sub>
21	TA <sub>o</sub>
22	TC <sub>o</sub>
23	PT <sub>l</sub>
24	λ
25	log RRATE ÷ log 2
26	DOC
27	STE
28	1 + mL
29	1 + TOR·L

Manpower Input/SAM  
Output

BANK 4

35	
31	
30	
03	TC <sub>o</sub> = 0
04	HRDW
05	STE
06	RPR
07	IEMC
08	DOC
09	M̄ <sub>m</sub>
10	
11	"IDEN"
12	q
13	
14	MTBF
15	r <sub>1</sub>
16	
17	
18	MTTRS
19	MTTR
20	TS
21	TC <sub>m</sub>
22	
23	
24	
25	
26	
27	
28	
29	

LRAM Output

BANK 3

35	
31	
30	
32	ΣTC <sub>m</sub> = 0
33	ΣTC <sub>o</sub> = 0
34	ΣHRDW = 0
35	ΣSTE = 0
36	ΣRPR = 0
37	ΣIEMC = 0
38	ΣDOC = 0
39	ΣM̄ <sub>m</sub> = 0
40	LCC = 0
41	ΣQIPA = 0
42	ΣMTBF = 0
43	ΣMTTR = 0
44	n hold
45	QIPA, M̄ <sub>o</sub> hold
46	R, A hold
47	"MWGE"
48	"MTRN"
49	"OWGE"
50	"OTRN"
51	"HRDW"
52	"STE"
53	"RPR"
54	"IEMC"
55	"DOC"
56	"LCC"
57	"MTBF"
58	"MTTR"
59	

Initialize/Aggregation  
Registers

**USER'S GUIDE SUPPLEMENT  
FOR SYSTEM CONFIDENCE MODEL**

Figure D-1 SCM Operating Instructions

Step	Procedure	Press	Printer/Display
1	Load Program	<b>CLR</b> (load Bank 1)	1.
2	Load Operating Environment Card	<b>CLR</b> (load Bank 3)	3.
3	Initialize	<b>A</b>	CONFIDENCE LEVEL $\infty$
4	Load Output Card for LRA	<b>CLR</b> (load Bank 4)	
5	Compute achieved confidence level, add to system confidence*	<b>B</b>	$K_i$ IDEN
6	Repeat Steps 4 and 5 for every LRA in the system		
7	Compute achieved system confidence	<b>D</b>	SYSTEM $\bar{K}$

\*If an LRA is added by mistake in Step 5, load the card in again and press **C**.

Figure D-2 SCM Memory Register Allocation

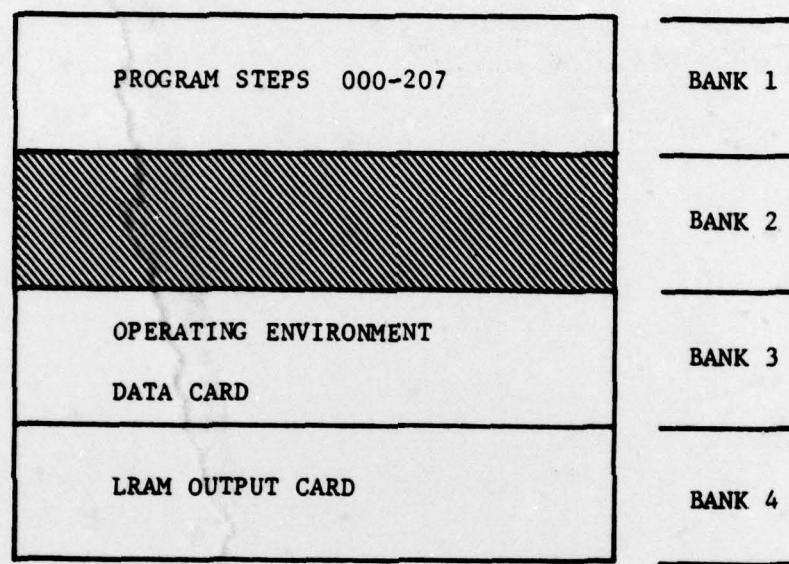


Figure D-3 SCM Data Register Listing

BANK 4

00	hold x
01	
02	
03	
04	
05	
06	
07	
08	
09	
10	K(XD)
11	"IDEN"
12	
13	
14	
15	
16	
17	
18	
19	
20	
21	
22	
23	
24	
25	
26	
27	
28	B. K(t)
29	

LRAM Output

BANK 3

30	
31	
32	s
33	
34	
35	
36	
37	N
38	DRT
39	
40	K = 1
41	hold
42	mult./divide reg.
43	
44	
45	
46	
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Op. Env. Data Card